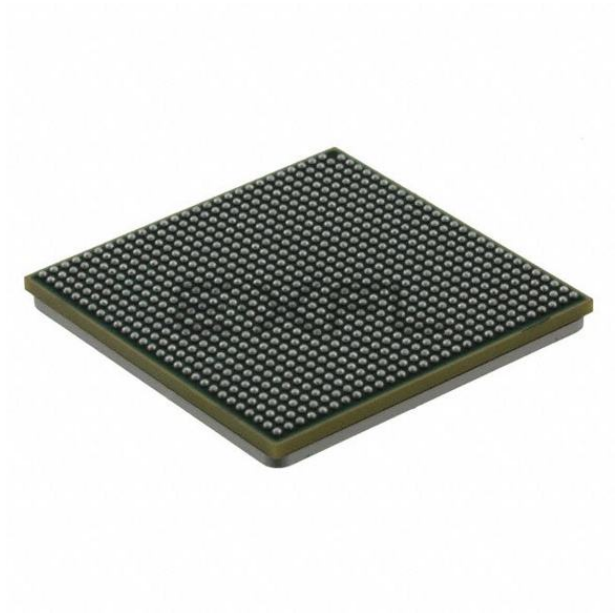

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Understanding Embedded - DSP (Digital Signal Processors)

Embedded - DSP (Digital Signal Processors) are specialized microprocessors designed to perform complex mathematical computations on digital signals in real-time. Unlike general-purpose processors, DSPs are optimized for high-speed numeric processing tasks, making them ideal for applications that require efficient and precise manipulation of digital data. These processors are fundamental in converting and processing signals in various forms, including audio, video, and communication signals, ensuring that data is accurately interpreted and utilized in embedded systems.

Applications of Embedded - DSP (Digital Signal Processors)

Details	
Product Status	Obsolete
Type	SC3850 Single Core
Interface	Ethernet, I²C, PCI, RGMII, Serial RapidIO, SGMII, SPI, UART/USART
Clock Rate	1GHz
Non-Volatile Memory	ROM (96kB)
On-Chip RAM	576kB
Voltage - I/O	2.50V
Voltage - Core	1.00V
Operating Temperature	0°C ~ 105°C (TJ)
Mounting Type	Surface Mount
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/msc8151sag1000b

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
B9	M2A13	O	GVDD2
B10	VSS	Ground	N/A
B11	GVDD2	Power	N/A
B12	$\overline{\text{M2CS1}}$	O	GVDD2
B13	VSS	Ground	N/A
B14	GVDD2	Power	N/A
B15	M2DQ35	I/O	GVDD2
B16	VSS	Ground	N/A
B17	GVDD2	Power	N/A
B18	M2DQ51	I/O	GVDD2
B19	VSS	Ground	N/A
B20	GVDD2	Power	N/A
B21	Reserved	NC	—
B22	Reserved	NC	—
B23	SR1_TXD0	O	SXPVDD1
B24	$\overline{\text{SR1\_TXD0}}$	O	SXPVDD1
B25	SXCVDD1	Power	N/A
B26	SXCVSS1	Ground	N/A
B27	$\overline{\text{SR1\_RXD0}}$	I	SXCVDD1
B28	SR1_RXD0	I	SXCVDD1
C1	M2DQ28	I/O	GVDD2
C2	M2DM3	O	GVDD2
C3	M2DQ26	I/O	GVDD2
C4	M2ECC4	I/O	GVDD2
C5	M2DM8	O	GVDD2
C6	M2ECC2	I/O	GVDD2
C7	M2CKE1	O	GVDD2
C8	M2CK0	O	GVDD2
C9	$\overline{\text{M2CK0}}$	O	GVDD2
C10	M2BA1	O	GVDD2
C11	M2A1	O	GVDD2
C12	$\overline{\text{M2WE}}$	O	GVDD2
C13	M2DQ37	I/O	GVDD2
C14	M2DM4	O	GVDD2
C15	M2DQ36	I/O	GVDD2
C16	M2DQ32	I/O	GVDD2
C17	M2DQ55	I/O	GVDD2
C18	M2DM6	O	GVDD2
C19	M2DQ53	I/O	GVDD2
C20	M2DQ52	I/O	GVDD2
C21	Reserved	NC	—
C22	SR1_IMP_CAL_RX	I	SXCVDD1
C23	SXPVSS1	Ground	N/A
C24	SXPVDD1	Power	N/A
C25	SR1_REF_CLK	I	SXCVDD1
C26	$\overline{\text{SR1\_REF\_CLK}}$	I	SXCVDD1

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
C27	Reserved	NC	—
C28	Reserved	NC	—
D1	GVDD2	Power	N/A
D2	VSS	Ground	N/A
D3	M2DQ29	I/O	GVDD2
D4	GVDD2	Power	N/A
D5	VSS	Ground	N/A
D6	M2ECC5	I/O	GVDD2
D7	GVDD2	Power	N/A
D8	VSS	Ground	N/A
D9	M2A8	O	GVDD2
D10	GVDD2	Power	N/A
D11	VSS	Ground	N/A
D12	M2A0	O	GVDD2
D13	GVDD2	Power	N/A
D14	VSS	Ground	N/A
D15	M2DQ39	I/O	GVDD2
D16	GVDD2	Power	N/A
D17	VSS	Ground	N/A
D18	M2DQ54	I/O	GVDD2
D19	GVDD2	Power	N/A
D20	VSS	Ground	N/A
D21	SXPVSS1	Ground	N/A
D22	SXPVDD1	Power	N/A
D23	SR1_TXD1	O	SXPVDD1
D24	$\overline{\text{SR1\_TXD1}}$	O	SXPVDD1
D25	SXCVSS1	Ground	N/A
D26	SXCVDD1	Power	N/A
D27	$\overline{\text{SR1\_RXD1}}$	I	SXCVDD1
D28	SR1_RXD1	I	SXCVDD1
E1	M2DQ31	I/O	GVDD2
E2	M2DQ30	I/O	GVDD2
E3	M2DQ27	I/O	GVDD2
E4	M2ECC7	I/O	GVDD2
E5	M2ECC6	I/O	GVDD2
E6	M2ECC3	I/O	GVDD2
E7	M2A9	O	GVDD2
E8	M2A6	O	GVDD2
E9	M2A3	O	GVDD2
E10	M2A10	O	GVDD2
E11	$\overline{\text{M2RAS}}$	O	GVDD2
E12	M2A2	O	GVDD2
E13	M2DQ38	I/O	GVDD2
E14	$\overline{\text{M2DQS5}}$	I/O	GVDD2
E15	M2DQS5	I/O	GVDD2
E16	M2DQ33	I/O	GVDD2

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
K15	VDD	Power	N/A
K16	VSS	Ground	N/A
K17	VSS	Ground	N/A
K18	VSS	Ground	N/A
K19	VDD	Power	N/A
K20	Reserved	NC	—
K21	Reserved	NC	—
K22	Reserved	NC	—
K23	SXPVDD2	Power	N/A
K24	SXPVSS2	Ground	N/A
K25	SXCVDD2	Power	N/A
K26	SXCVSS2	Ground	N/A
K27	SXCVDD2	Power	N/A
K28	SXCVSS2	Ground	N/A
L1	M2DQ9	I/O	GVDD2
L2	M2DQ12	I/O	GVDD2
L3	M2DQ13	I/O	GVDD2
L4	$\overline{\text{M2DQS0}}$	I/O	GVDD2
L5	M2DQS0	I/O	GVDD2
L6	M2DM0	O	GVDD2
L7	M2DQ3	I/O	GVDD2
L8	M2DQ2	I/O	GVDD2
L9	M2DQ4	I/O	GVDD2
L10	VDD	Power	N/A
L11	VSS	Ground	N/A
L12	M3VDD	Power	N/A
L13	VSS	Ground	N/A
L14	VSS	Ground	N/A
L15	VSS	Ground	N/A
L16	VSS	Ground	N/A
L17	VSS	Ground	N/A
L18	VDD	Power	N/A
L19	VSS	Ground	N/A
L20	Reserved	NC	—
L21	Reserved	NC	—
L22	Reserved	NC	—
L23	SR2_TXD3/PE_TXD3/SG2_TX[4]	O	SXPVDD2
L24	$\overline{\text{SR2\_TXD3}}/\overline{\text{PE\_TXD3}}/\overline{\text{SG2\_TX}}$[4]	O	SXPVDD2
L25	SXCVSS2	Ground	N/A
L26	SXCVDD2	Power	N/A
L27	$\overline{\text{SR2\_RXD3}}/\overline{\text{PE\_RXD3}}/\overline{\text{SG2\_RX}}$[4]	I	SXCVDD2
L28	SR2_RXD3/PE_RXD3/SG2_RX[4]	I	SXCVDD2
M1	M2DQ8	I/O	GVDD2
M2	VSS	Ground	N/A
M3	GVDD2	Power	N/A
M4	M2DQ15	I/O	GVDD2

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
R13	VSS	Ground	N/A
R14	VDD	Power	N/A
R15	VSS	Ground	N/A
R16	MVDD	Power	N/A
R17	VSS	Ground	N/A
R18	VDD	Power	N/A
R19	VSS	Ground	N/A
R20	VSS	Non-user	N/A
R21	SXPVSS2	Ground	N/A
R22	SXPVDD2	Power	N/A
R23	SR2_TXD1/PE_TXD1[4]	O	SXPVDD2
R24	$\overline{\text{SR2\_TXD1}}/\overline{\text{PE\_TXD1}}$[4]	O	SXPVDD2
R25	SXCVSS2	Ground	N/A
R26	SXCVDD2	Power	N/A
R27	$\overline{\text{SR2\_RXD1}}/\overline{\text{PE\_RXD1}}$[4]	I	SXCVDD2
R28	SR2_RXD1/PE_RXD1[4]	I	SXCVDD2
T1	VSS	Ground	N/A
T2	TCK	I	QVDD
T3	$\overline{\text{SRESET}}$[6,7]	I/O	QVDD
T4	TDI	I	QVDD
T5	VSS	Ground	N/A
T6	TDO	O	QVDD
T7	VSS	Ground	N/A
T8	VSS	Ground	N/A
T9	QVDD	Power	N/A
T10	VSS	Ground	N/A
T11	VDD	Power	N/A
T12	VSS	Ground	N/A
T13	M3VDD	Power	N/A
T14	VSS	Ground	N/A
T15	VDD	Power	N/A
T16	VSS	Ground	N/A
T17	MVDD	Power	N/A
T18	VSS	Ground	N/A
T19	VDD	Power	N/A
T20	VSS	Ground	N/A
T21	VSS	Non-user	N/A
T22	SR2_IMP_CAL_RX	I	SXCVDD2
T23	SXPVSS2	Ground	N/A
T24	SXPVDD2	Power	N/A
T25	SR2_REF_CLK	I	SXCVDD2
T26	$\overline{\text{SR2\_REF\_CLK}}$	I	SXCVDD2
T27	Reserved	NC	—
T28	Reserved	NC	—
U1	M1DQ8	I/O	GVDD1
U2	VSS	Ground	N/A

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
U3	GVDD1	Power	N/A
U4	M1DQ15	I/O	GVDD1
U5	M1DQ1	I/O	GVDD1
U6	VSS	Ground	N/A
U7	GVDD1	Power	N/A
U8	M1DQ7	I/O	GVDD1
U9	M1DQ6	I/O	GVDD1
U10	VDD	Power	N/A
U11	VSS	Ground	N/A
U12	M3VDD	Power	N/A
U13	VSS	Ground	N/A
U14	VDD	Power	N/A
U15	VSS	Ground	N/A
U16	VDD	Power	N/A
U17	VSS	Ground	N/A
U18	VDD	Power	N/A
U19	VSS	Ground	N/A
U20	VSS	Ground	N/A
U21	VSS	Ground	N/A
U22	VSS	Non-user	N/A
U23	SR2_TXD0/PE_TXD0[4]	O	SXPVDD2
U24	$\overline{\text{SR2\_TXD0}}/\overline{\text{PE\_TXD0}}$[4]	O	SXPVDD2
U25	SXCVDD2	Power	N/A
U26	SXCVSS2	Ground	N/A
U27	$\overline{\text{SR2\_RXD0}}/\overline{\text{PE\_RXD0}}$[4]	I	SXCVDD2
U28	SR2_RXD0/PE_RXD0[4]	I	SXCVDD2
V1	M1DQ9	I/O	GVDD1
V2	M1DQ12	I/O	GVDD1
V3	M1DQ13	I/O	GVDD1
V4	$\overline{\text{M1DQS0}}$	I/O	GVDD1
V5	M1DQS0	I/O	GVDD1
V6	M1DM0	O	GVDD1
V7	M1DQ3	I/O	GVDD1
V8	M1DQ2	I/O	GVDD1
V9	M1DQ4	I/O	GVDD1
V10	VSS	Ground	N/A
V11	VDD	Power	N/A
V12	VSS	Ground	N/A
V13	VDD	Power	N/A
V14	VSS	Ground	N/A
V15	VDD	Power	N/A
V16	VSS	Ground	N/A
V17	VDD	Power	N/A
V18	VSS	Ground	N/A
V19	VDD	Power	N/A
V20	NVDD	Power	N/A

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
AB1	$\overline{\text{M1DQS2}}$	I/O	GVDD1
AB2	M1DQS2	I/O	GVDD1
AB3	M1DQ19	I/O	GVDD1
AB4	M1DM2	O	GVDD1
AB5	M1DQ21	I/O	GVDD1
AB6	M1DQ22	I/O	GVDD1
AB7	M1CKE0	O	GVDD1
AB8	M1A11	O	GVDD1
AB9	M1A7	O	GVDD1
AB10	$\overline{\text{M1CK2}}$	O	GVDD1
AB11	M1APAR_OUT	O	GVDD1
AB12	M1ODT1	O	GVDD1
AB13	$\overline{\text{M1APAR\_IN}}$	I	GVDD1
AB14	M1DQ43	I/O	GVDD1
AB15	M1DM5	O	GVDD1
AB16	M1DQ44	I/O	GVDD1
AB17	M1DQ40	I/O	GVDD1
AB18	M1DQ59	I/O	GVDD1
AB19	M1DM7	O	GVDD1
AB20	M1DQ60	I/O	GVDD1
AB21	VSS	Ground	N/A
AB22	GPIO31/I2C_SDA[5,8]	I/O	NVDD
AB23	GPIO27/TMR4/RCW_SRC0[5,8]	I/O	NVDD
AB24	GPIO25/TMR2/RCW_SRC1[5,8]	I/O	NVDD
AB25	GPIO24/TMR1/RCW_SRC2[5,8]	I/O	NVDD
AB26	GPIO10/$\overline{\text{IRQ10}}$/RC10[5,8]	I/O	NVDD
AB27	GPIO5/$\overline{\text{IRQ5}}$/RC5[5,8]	I/O	NVDD
AB28	GPIO0/$\overline{\text{IRQ0}}$/RC0[5,8]	I/O	NVDD
AC1	VSS	Ground	N/A
AC2	GVDD1	Power	N/A
AC3	M1DQ16	I/O	GVDD1
AC4	VSS	Ground	N/A
AC5	GVDD1	Power	N/A
AC6	M1DQ17	I/O	GVDD1
AC7	VSS	Ground	N/A
AC8	GVDD1	Power	N/A
AC9	M1BA2	O	GVDD1
AC10	VSS	Ground	N/A
AC11	GVDD1	Power	N/A
AC12	M1A4	O	GVDD1
AC13	VSS	Ground	N/A
AC14	GVDD1	Power	N/A
AC15	M1DQ42	I/O	GVDD1
AC16	VSS	Ground	N/A
AC17	GVDD1	Power	N/A
AC18	M1DQ58	I/O	GVDD1

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
AC19	VSS	Ground	N/A
AC20	GVDD1	Power	N/A
AC21	VSS	Ground	N/A
AC22	NVDD	Power	N/A
AC23	GPIO30/I2C_SCL[5,8]	I/O	NVDD
AC24	GPIO26/TMR3[5,8]	I/O	NVDD
AC25	VSS	Ground	N/A
AC26	NVDD	Power	N/A
AC27	GPIO23/TMR0[5,8]	I/O	NVDD
AC28	GPIO22[5,8]	I/O	NVDD
AD1	M1DQ31	I/O	GVDD1
AD2	M1DQ30	I/O	GVDD1
AD3	M1DQ27	I/O	GVDD1
AD4	M1ECC7	I/O	GVDD1
AD5	M1ECC6	I/O	GVDD1
AD6	M1ECC3	I/O	GVDD1
AD7	M1A9	O	GVDD1
AD8	M1A6	O	GVDD1
AD9	M1A3	O	GVDD1
AD10	M1A10	O	GVDD1
AD11	$\overline{\text{M1RAS}}$	O	GVDD1
AD12	M1A2	O	GVDD1
AD13	M1DQ38	I/O	GVDD1
AD14	$\overline{\text{M1DQS}}$5	I/O	GVDD1
AD15	M1DQS5	I/O	GVDD1
AD16	M1DQ33	I/O	GVDD1
AD17	M1DQ56	I/O	GVDD1
AD18	M1DQ57	I/O	GVDD1
AD19	$\overline{\text{M1DQS7}}$	I/O	GVDD1
AD20	M1DQS7	I/O	GVDD1
AD21	VSS	Ground	N/A
AD22	GE2_TX_CTL	O	NVDD
AD23	GPIO15/DDN0/$\overline{\text{IRQ15}}$/RC15[5,8]	I/O	NVDD
AD24	GPIO13/$\overline{\text{IRQ13}}$/RC13[5,8]	I/O	NVDD
AD25	GE_MDC	O	NVDD
AD26	GE_MDIO	I/O	NVDD
AD27	TDM2TCK/GE1_TD3[3]	I/O	NVDD
AD28	TDM2RCK/GE1_TD0[3]	I/O	NVDD
AE1	GVDD1	Power	N/A
AE2	VSS	Ground	N/A
AE3	M1DQ29	I/O	GVDD1
AE4	GVDD1	Power	N/A
AE5	VSS	Ground	N/A
AE6	M1ECC5	I/O	GVDD1
AE7	GVDD1	Power	N/A
AE8	VSS	Ground	N/A

Table 1. Signal List by Ball Number (continued)

Ball Number	Signal Name[1,2]	Pin Type[10]	Power Rail Name
AE9	M1A8	O	GVDD1
AE10	GVDD1	Power	N/A
AE11	VSS	Ground	N/A
AE12	M1A0	O	GVDD1
AE13	GVDD1	Power	N/A
AE14	VSS	Ground	N/A
AE15	M1DQ39	I/O	GVDD1
AE16	GVDD1	Power	N/A
AE17	VSS	Ground	N/A
AE18	M1DQ54	I/O	GVDD1
AE19	GVDD1	Power	N/A
AE20	VSS	Ground	N/A
AE21	GPIO29/UART_TXD[5,8]	I/O	NVDD
AE22	TDM1TCK/GE2_RX_CLK[3]	I	NVDD
AE23	TDM1RSN/GE2_RX_CTL[3]	I/O	NVDD
AE24	VSS	Ground	N/A
AE25	TDM3RCK/GE1_GTX_CLK[3]	I/O	NVDD
AE26	TDM3TSN/GE1_RX_CLK[3]	I/O	NVDD
AE27	TDM2RSN/GE1_TD2[3]	I/O	NVDD
AE28	TDM2RDT/GE1_TD1[3]	I/O	NVDD
AF1	M1DQ28	I/O	GVDD1
AF2	M1DM3	O	GVDD1
AF3	M1DQ26	I/O	GVDD1
AF4	M1ECC4	I/O	GVDD1
AF5	M1DM8	O	GVDD1
AF6	M1ECC2	I/O	GVDD1
AF7	M1CKE1	O	GVDD1
AF8	M1CK0	O	GVDD1
AF9	$\overline{\text{M1CK0}}$	O	GVDD1
AF10	M1BA1	O	GVDD1
AF11	M1A1	O	GVDD1
AF12	$\overline{\text{M1WE}}$	O	GVDD1
AF13	M1DQ37	I/O	GVDD1
AF14	M1DM4	O	GVDD1
AF15	M1DQ36	I/O	GVDD1
AF16	M1DQ32	I/O	GVDD1
AF17	M1DQ55	I/O	GVDD1
AF18	M1DM6	O	GVDD1
AF19	M1DQ53	I/O	GVDD1
AF20	M1DQ52	I/O	GVDD1
AF21	GPIO28/UART_RXD[5,8]	I/O	NVDD
AF22	TDM0RSN/GE2_TD2[3]	I/O	NVDD
AF23	TDM0TDT/GE2_TD3[3]	I/O	NVDD
AF24	NVDD	Power	N/A
AF25	TDM2TSN/GE1_TX_CTL[3]	I/O	NVDD
AF26	GE1_RX_CTL	I	NVDD

Using this waveform, the definitions are listed in Table 10. To simplify the illustration, the definitions assume that the SerDes transmitter and receiver operate in a fully symmetrical differential signalling environment.

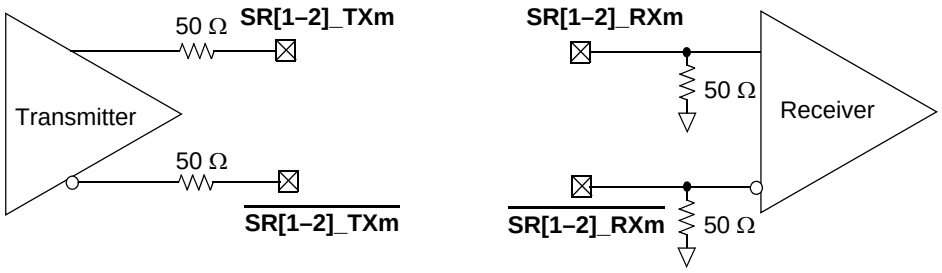
Table 10. Differential Signal Definitions

Term	Definition
Single-Ended Swing	The transmitter output signals and the receiver input signals SR[1–2]_TX, $\overline{\text{SR[1–2]\_TX}}$, SR[1–2]_RX and $\overline{\text{SR[1–2]\_RX}}$ each have a peak-to-peak swing of A – B volts. This is also referred to as each signal wire's single-ended swing.
Differential Output Voltage, V_{OD} (or **Differential Output Swing**):	The differential output voltage (or swing) of the transmitter, V_{OD}, is defined as the difference of the two complimentary output voltages: $V_{SR[1–2]\_TX} - V_{\overline{SR[1–2]\_TX}}$. The V_{OD} value can be either positive or negative.
Differential Input Voltage, V_{ID} (or **Differential Input Swing**)	The differential input voltage (or swing) of the receiver, V_{ID}, is defined as the difference of the two complimentary input voltages: $V_{SR[1–2]\_RX} - V_{\overline{SR[1–2]\_RX}}$. The V_{ID} value can be either positive or negative.
Differential Peak Voltage, V_{DIFFp}	The peak value of the differential transmitter output signal or the differential receiver input signal is defined as the differential peak voltage, $V_{DIFFp} = \|A – B\|$ volts.
Differential Peak-to-Peak, $V_{DIFFp-p}$	Since the differential output signal of the transmitter and the differential input signal of the receiver each range from A – B to –(A – B) volts, the peak-to-peak value of the differential transmitter output signal or the differential receiver input signal is defined as differential peak-to-peak voltage, $V_{DIFFp-p} = 2 \times V_{DIFFp} = 2 \times \|(A – B)\|$ volts, which is twice the differential swing in amplitude, or twice of the differential peak. For example, the output differential peak-peak voltage can also be calculated as $V_{TX-DIFFp-p} = 2 \times \|V_{OD}\|$.
Differential Waveform	The differential waveform is constructed by subtracting the inverting signal ($\overline{\text{SR[1–2]\_TX}}$, for example) from the non-inverting signal (SR[1–2]_TX, for example) within a differential pair. There is only one signal trace curve in a differential waveform. The voltage represented in the differential waveform is not referenced to ground. Refer to Figure 16 as an example for differential waveform.
Common Mode Voltage, V_{cm}	The common mode voltage is equal to half of the sum of the voltages between each conductor of a balanced interchange circuit and ground. In this example, for SerDes output, $V_{cm\_out} = (V_{SR[1–2]\_TX} + V_{\overline{SR[1–2]\_TX}}) \div 2 = (A + B) \div 2$, which is the arithmetic mean of the two complimentary output voltages within a differential pair. In a system, the common mode voltage may often differ from one component's output to the other's input. It may be different between the receiver input and driver output circuits within the same component. It is also referred to as the DC offset on some occasions.

To illustrate these definitions using real values, consider the example of a current mode logic (CML) transmitter that has a common mode voltage of 2.25 V and outputs, TD and $\overline{\text{TD}}$. If these outputs have a swing from 2.0 V to 2.5 V, the peak-to-peak voltage swing of each signal (TD or $\overline{\text{TD}}$) is 500 mV p-p, which is referred to as the single-ended swing for each signal. Because the differential signaling environment is fully symmetrical in this example, the transmitter output differential swing (V_{OD}) has the same amplitude as each signal single-ended swing. The differential output signal ranges between 500 mV and –500 mV. In other words, V_{OD} is 500 mV in one phase and –500 mV in the other phase. The peak differential voltage (V_{DIFFp}) is 500 mV. The peak-to-peak differential voltage ($V_{DIFFp-p}$) is 1000 mV p-p.

2.5.2.3 SerDes Transmitter and Receiver Reference Circuits

Figure 6 shows the reference circuits for SerDes data lane transmitter and receiver.



Note: The [1–2] indicates the specific SerDes Interface (1 or 2) and the m indicates the specific channel within that interface (0,1,2,3). Actual signals are assigned by the HRCW assignments at reset (see **Chapter 5**, *Reset* in the reference manual for details)

Figure 6. SerDes Transmitter and Receiver Reference Circuits

2.5.3 DC-Level Requirements for SerDes Interfaces

The following subsections define the DC-level requirements for the SerDes reference clocks, the PCI Express data lines, the Serial RapidIO data lines, and the SGMII data lines.

2.5.3.1 DC-Level Requirements for SerDes Reference Clocks

The DC-level requirement for the SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs, as described below:

- Differential Mode
  - The input amplitude of the differential clock must be between 400 mV and 1600 mV differential peak-peak (or between 200 mV and 800 mV differential peak). In other words, each signal wire of the differential pair must have a single-ended swing of less than 800 mV and greater than 200 mV. This requirement is the same for both external DC-coupled or AC-coupled connection.
  - For an external DC-coupled connection, the maximum average current requirements sets the requirement for average voltage (common mode voltage) as between 100 mV and 400 mV. Figure 7 shows the SerDes reference clock input requirement for DC-coupled connection scheme.

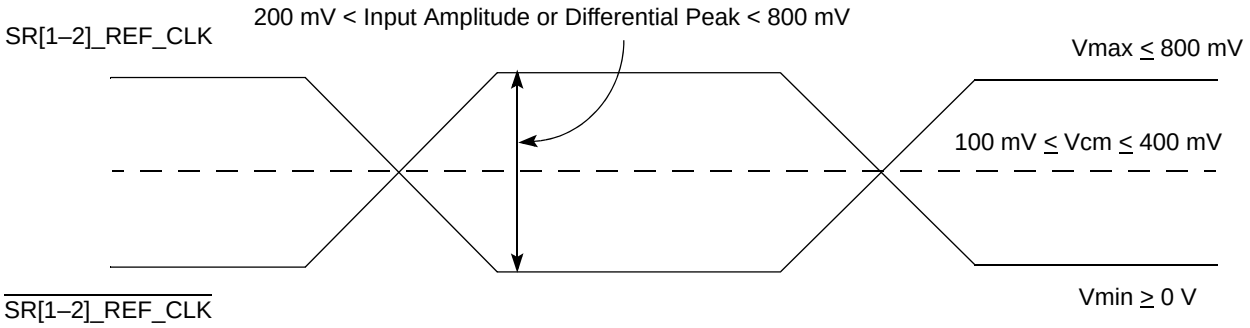


Figure 7. Differential Reference Clock Input DC Requirements (External DC-Coupled)

Note: Specifications are valid at the recommended operating conditions listed in Table 3.

Table 11. PCI Express (2.5 Gbps) Differential Transmitter (Tx) Output DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential peak-to-peak output voltage	$V_{TX-DIFFp-p}$	800	1000	1200	mV	1
De-emphasized differential output voltage (ratio)	$V_{TX-DE-RATIO}$	3.0	3.5	4.0	dB	2
DC differential Tx impedance	$Z_{TX-DIFF-DC}$	80	100	120	Ω	3
Transmitter DC impedance	Z_{TX-DC}	40	50	60	Ω	4

Notes:
1. $V_{TX-DIFFp-p} = 2 \times |V_{TX-D+} - V_{TX-D-}|$ Measured at the package pins with a test load of 50 Ω to GND on each pin.
2. Ratio of the $V_{TX-DIFFp-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFp-p}$ of the first bit after a transition. Measured at the package pins with a test load of 50 Ω to GND on each pin.
3. Tx DC differential mode low impedance
4. Required Tx D+ as well as D– DC Impedance during all states

Table 12. PCI Express (2.5 Gbps) Differential Receiver (Rx) Input DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Differential input peak-to-peak voltage	$V_{RX-DIFFp-p}$	120	1000	1200	mV	1
DC differential Input Impedance	$Z_{RX-DIFF-DC}$	80	100	120	Ω	2
DC input impedance	Z_{RX-DC}	40	50	60	Ω	3
Powered down DC input impedance	$Z_{RX-HIGH-IMP-DC}$	50	—	—	KΩ	4
Electrical idle detect threshold	$V_{RX-IDLE-DET-DIFFp-p}$	65	—	175	mV	5

Notes:
1. $V_{RX-DIFFp-p} = 2 \times |V_{RX-D+} - V_{RX-D-}|$ Measured at the package pins with a test load of 50 Ω to GND on each pin.
2. Rx DC differential mode impedance. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM), there is a 5 ms transition time before the receiver termination values must be met on all unconfigured lanes of a port.
3. Required Rx D+ as well as D– DC Impedance (50 ±20% tolerance). Measured at the package pins with a test load of 50 Ω to GND on each pin. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM), there is a 5 ms transition time before the receiver termination values must be met on all unconfigured lanes of a port.
4. Required Rx D+ as well as D– DC Impedance when the receiver terminations do not have power. The Rx DC common mode impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the Rx ground.
5. $V_{RX-IDLE-DET-DIFFp-p} = 2 \times |V_{RX-D+} - V_{RX-D-}|$. Measured at the package pins of the receiver

2.5.3.3 DC-Level Requirements for Serial RapidIO Configurations

This sections provided various DC-level requirements for Serial RapidIO Configurations.

Note: Specifications are valid at the recommended operating conditions listed in Table 3.

Table 13. Serial RapidIO Transmitter DC Specifications

Parameter	Symbol	Min	Typical	Max	Units	Notes
Output voltage	V_O	–0.40	—	2.30	V	1
Long run differential output voltage	V_{DIFFPP}	800	—	1600	mVp-p	—
Short run differential output voltage	V_{DIFFPP}	500	—	1000	mVp-p	—

Note: Voltage relative to COMMON of either signal comprising a differential pair.

Figure 11 shows the DDR2 and DDR3 SDRAM interface input timing diagram.

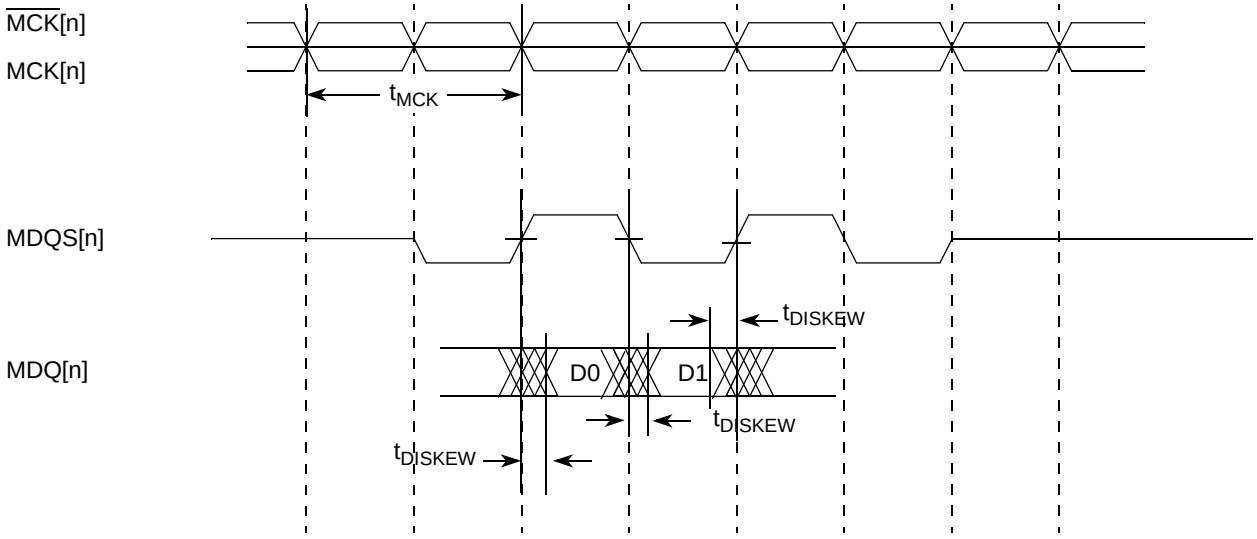


Figure 11. DDR2 and DDR3 SDRAM Interface Input Timing Diagram

2.6.1.2 DDR SDRAM Output AC Timing Specifications

Table 21 provides the output AC timing specifications for the DDR SDRAM interface.

Table 21. DDR SDRAM Output AC Timing Specifications

Parameter	Symbol [1]	Min	Max	Unit	Notes
MCK[n] cycle time	t_{MCK}	2.5	5	ns	2
ADDR/CMD output setup with respect to MCK • 800 MHz data rate • 667 MHz data rate	t_{DDKHAS}	 0.917 1.10	 — —	 ns ns	3
ADDR/CMD output hold with respect to MCK • 800 MHz data rate • 667 MHz data rate	t_{DDKHAX}	 0.767 1.02	 — —	 ns ns	3
$\overline{\text{MCS}}$n output setup with respect to MCK • 800 MHz data rate • 667 MHz data rate	t_{DDKHCS}	 0.917 1.10	 — —	 ns ns	3
$\overline{\text{MCS}}$n output hold with respect to MCK • 800 MHz data rate • 667 MHz data rate	t_{DDKHCX}	 0.767 1.02	 — —	 ns ns	3
MCK to MDQS Skew • 800 MHz data rate • 667 MHz data rate	t_{DDKHMH}	 –0.4 –0.6	 0.375 0.6	ns	4
MDQ/MECC/MDM output setup with respect to MDQS • 800 MHz • 667 MHz	t_{DDKHDS}, t_{DDKLDS}	 300 375	 — —	 ps ps	5
MDQ/MECC/MDM output hold with respect to MDQS • 800 MHz • 667 MHz	t_{DDKHDX}, t_{DDKLDX}	 300 375	 — —	 ps ps	5
MDQS preamble	t_{DDKHMP}	$-0.9 \times t_{MCK}$	—	ns	—
MDQS postamble	t_{DDKHME}	$-0.4 \times t_{MCK}$	$-0.6 \times t_{MCK}$	ns	—

Table 22 provides the DDR2 differential specifications for the differential signals MDQS/$\overline{\text{MDQS}}$ and MCK/$\overline{\text{MCK}}$.

Table 22. DDR2 SDRAM Differential Electrical Characteristics

Parameter	Symbol	Min	Max	Unit
Input AC differential cross-point voltage	V_{IXAC}	0.5 × GVDD – 0.175	0.5 × GVDD + 0.175	V
Output AC differential cross-point voltage	V_{OXAC}	0.5 × GVDD – 0.125	0.5 × GVDD + 0.125	V

Table 23 provides the DDR3 differential specifications for the differential signals MDQS/$\overline{\text{MDQS}}$ and MCK/$\overline{\text{MCK}}$.

Table 23. DDR3 SDRAM Differential Electrical Characteristics

Parameter	Symbol	Min	Max	Unit
Input AC differential cross-point voltage	V_{IXAC}	0.5 × GVDD – 0.150	0.5 × GVDD + 0.150	V
Output AC differential cross-point voltage	V_{OXAC}	0.5 × GVDD – 0.115	0.5 × GVDD + 0.115	V

2.6.2 HSSI AC Timing Specifications

The following subsections define the AC timing requirements for the SerDes reference clocks, the PCI Express data lines, the Serial RapidIO data lines, and the SGMII data lines.

2.6.2.1 AC Requirements for SerDes Reference Clock

Table 24 lists AC requirements for the SerDes reference clocks.

Note: Specifications are valid at the recommended operating conditions listed in Table 3.

Table 24. SR[1–2]_REF_CLK and $\overline{\text{SR[1–2]\_REF\_CLK}}$ Input Clock Requirements

Parameter	Symbol	Min	Typical	Max	Units	Notes
SR[1–2]_REF_CLK/$\overline{\text{SR[1–2]\_REF\_CLK}}$ frequency range	t_{CLK_REF}	—	100/125	—	MHz	1
SR[1–2]_REF_CLK/$\overline{\text{SR[1–2]\_REF\_CLK}}$ clock frequency tolerance	t_{CLK_TOL}	–350	—	350	ppm	—
SR[1–2]_REF_CLK/$\overline{\text{SR[1–2]\_REF\_CLK}}$ reference clock duty cycle (measured at 1.6 V)	t_{CLK_DUTY}	40	50	60	%	—
SR[1–2]_REF_CLK/$\overline{\text{SR[1–2]\_REF\_CLK}}$ max deterministic peak-peak jitter at 10^{-6} BER	t_{CLK_DJ}	—	—	42	ps	—
SR[1–2]_REF_CLK/$\overline{\text{SR[1–2]\_REF\_CLK}}$ total reference clock jitter at 10^{-6} BER (peak-to-peak jitter at ref_clk input)	t_{CLK_TJ}	—	—	86	ps	2
SR[1–2]_REF_CLK/$\overline{\text{SR[1–2]\_REF\_CLK}}$ rising/falling edge rate	t_{CLKRR}/t_{CLKFR}	1	—	4	V/ns	3
Differential input high voltage	V_{IH}	200	—	—	mV	4
Differential input low voltage	V_{IL}	—	—	–200	mV	4
Rising edge rate (SR[1–2]_REF_CLK) to falling edge rate (SR[1–2]_REF_CLK) matching	Rise-Fall Matching	—	—	20	%	5, 6

2.6.7 Asynchronous Signal Timing

Table 35 lists the asynchronous signal timing specifications.

Table 37. Signal Timing

Characteristics	Symbol	Type	Min
Input	t_{IN}	Asynchronous	One CLKIN cycle
Output	t_{OUT}	Asynchronous	Application dependent
Note: Input value relevant for EE0, $\overline{\text{IRQ}}$[15–0], and $\overline{\text{NMI}}$ only.			

The following interfaces use the specified asynchronous signals:

- *GPIO*. Signals GPIO[31–0], when used as GPIO signals, that is, when the alternate multiplexed special functions are not selected.

Note: When used as a general purpose input (GPI), the input signal should be driven until it is acknowledged by the MSC8151 device, that is, when the expected input value is read from the GPIO data register.

- *EE port*. Signals EE0, EE1.
- *Boot function*. Signal STOP_BS.
- *I^2C interface*. Signals I2C_SCL and I2C_SDA.
- *Interrupt inputs*. Signals $\overline{\text{IRQ}}$[15–0] and $\overline{\text{NMI}}$.
- *Interrupt outputs*. Signals $\overline{\text{INT\_OUT}}$ and $\overline{\text{NMI\_OUT}}$ (minimum pulse width is 32 ns).

2.6.8 JTAG Signals

Table 38 lists the JTAG timing specifications shown in Figure 29 through Figure 32.

Table 38. JTAG Timing

Characteristics	Symbol	All frequencies		Unit
		Min	Max	
TCK cycle time	t_{TCKX}	36.0	—	ns
TCK clock high phase measured at $V_M = V_{DDIO}/2$	t_{TCKH}	15.0	—	ns
Boundary scan input data setup time	t_{BSVKH}	0.0	—	ns
Boundary scan input data hold time	t_{BSXKH}	15.0	—	ns
TCK fall to output data valid	t_{TCKHOV}	—	20.0	ns
TCK fall to output high impedance	t_{TCKHOZ}	—	24.0	ns
TMS, TDI data setup time	t_{TDIVKH}	0.0	—	ns
TMS, TDI data hold time	t_{TDIXKH}	5.0	—	ns
TCK fall to TDO data valid	t_{TDOHOV}	—	10.0	ns
TCK fall to TDO high impedance	t_{TDOHOZ}	—	12.0	ns
$\overline{\text{TRST}}$ assert time	t_{TRST}	100.0	—	ns
Note: All timings apply to OnCE module data transfers as well as any other transfers via the JTAG port.				

Figure 29 shows the test clock input timing diagram

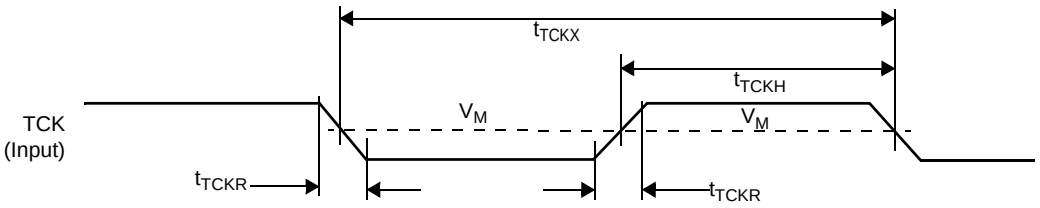


Figure 29. Test Clock Input Timing

3.1.2 Power-On Ramp Time

This section describes the AC electrical specification for the power-on ramp rate requirements for all voltage supplies (including GVDD/SXPVDD/SXCVDD/QVDD/GVDD/NVDD, all VDD supplies, MVREF, and all AVDD supplies). Controlling the power-on ramp time is required to avoid falsely triggering the ESD circuitry. Table 39 defines the power supply ramp time specification.

Table 39. Power Supply Ramp Rate

Parameter	Min	Max	Unit
Required ramp rate.	—	36000	V/s

Notes:
1. Ramp time is specified as a linear ramp from 10% to 90% of nominal voltage of the specific voltage supply. If the ramp is non-linear (for example, exponential), the maximum rate of change from 200 to 500 mV is the most critical because this range might falsely trigger the ESD circuitry.
2. Required over the full recommended operating temperature range (see Table 3).
3. All supplies must be at their stable values within 50 ms.
4. The GVDD pins can be held low on the application board at powerup. If GVDD is not held low, then GVDD will rise to a voltage level that depends on the board-level impedance-to-ground. If the impedance is high (that is, infinite), then theoretically, GVDD can rise up close to the VDD levels.

3.1.3 Power Supply Guidelines

Use the following guidelines for power-up sequencing:

- Couple M3VDD with the VDD power rail using an extremely low impedance path.
- Couple inputs PLL1_AVDD, PLL2_AVDD and PLL3_AVDD with the VDD power rail using an RC filter (see Figure 37).
- There is no dependency in power-on/power-off sequence between the GVDD1, GVDD2, NVDD, and QVDD power rails.
- Couple inputs M1VREF and M2VREF with the GVDD1 and GVDD2 power rails, respectively. They should rise at the same time as or after their respective power rail.
- There is no dependency between RapidIO supplies: SXCVDD1, SXCVDD2, SXPVDD1 and SXPVDD2 and other MSC8151 supplies in the power-on/power-off sequence
- Couple inputs SR1_PLL_AVDD and SR2_PLL_AVDD with SXCVDD1 and SXCVDD2 power rails, respectively, using an RC filter (see Figure 38).

External voltage applied to any input line must not exceed the I/O supply voltage related to this line by more than 0.6 V at any time, including during power-up. Some designs require pull-up voltages applied to selected input lines during power-up for configuration purposes. This is an acceptable exception to the rule during start-up. However, each such input can draw up to 80 mA per input pin per MSC8151 device in the system during power-up. An assertion of the inputs to the high voltage level before power-up should be with slew rate less than 4 V/ns.

The device power rails should rise in the following sequence:

1. VDD (and all coupled supplies)

3.2 PLL Power Supply Design Considerations

Each global PLL power supply must have an external RC filter for the PLLn_AVDD input (see Figure 37) in which the following components are defined as listed:

- R = 5 Ω ± 5%
- C1 = 10 µF ± 10%, 0603, X5R, with ESL ≤ 0.5 nH, low ESL Surface Mount Capacitor.
- C2 = 1.0 µF ± 10%, 0402, X5R, with ESL ≤ 0.5 nH, low ESL Surface Mount Capacitor.

Note: A higher capacitance value for C2 may be used to improve the filter as long as the other C2 parameters do not change.

All three PLLs can connect to a single supply voltage source (such as a voltage regulator) as long as the external RC filter is applied to each PLL separately. For optimal noise filtering, place the circuit as close as possible to its PLLn_AVDD inputs.

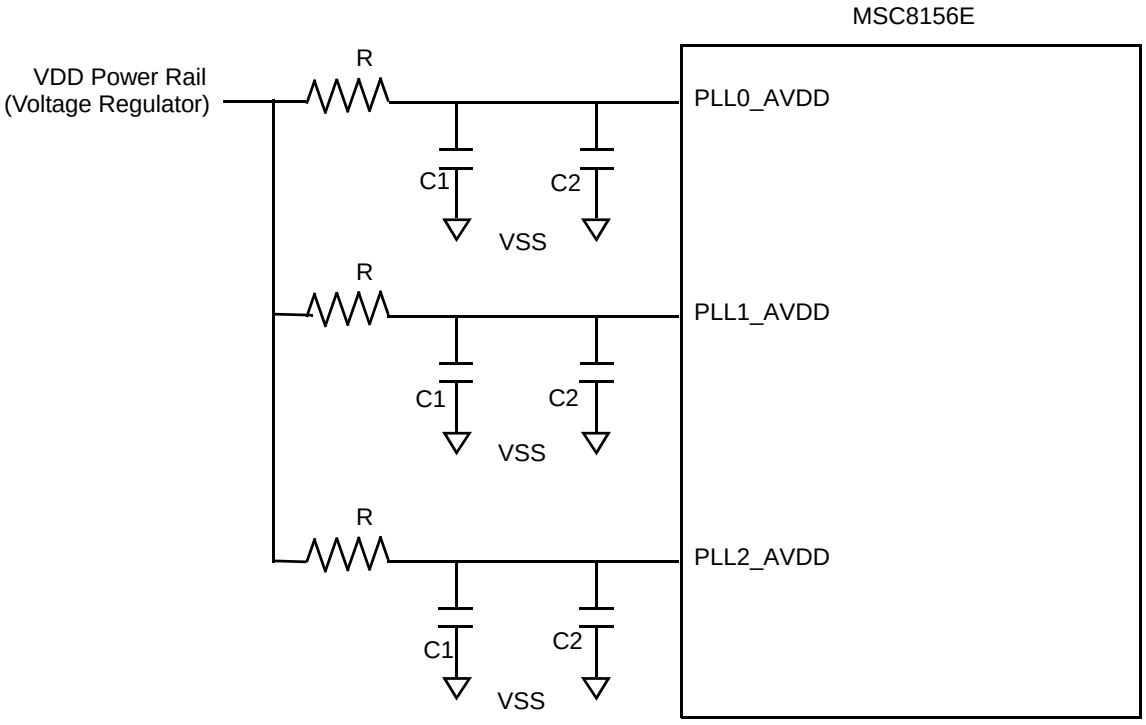


Figure 37. PLL Supplies

Each SerDes PLL power supply must be filtered using a circuit similar to the one shown in Figure 38, to ensure stability of the internal clock. For maximum effectiveness, the filter circuit should be placed as closely as possible to the SRn_PLL_AVDD ball to ensure it filters out as much noise as possible. The ground connection should be near the SRn_PLL_AVDD ball. The 0.003 µF capacitor is closest to the ball, followed by the two 2.2 µF capacitors, and finally the 1 Ω resistor to the board supply plane. The capacitors are connected from SRn_PLL_AVDD to the ground plane. Use ceramic chip capacitors with the highest possible self-resonant frequency. All trances should be kept short, wide, and direct.

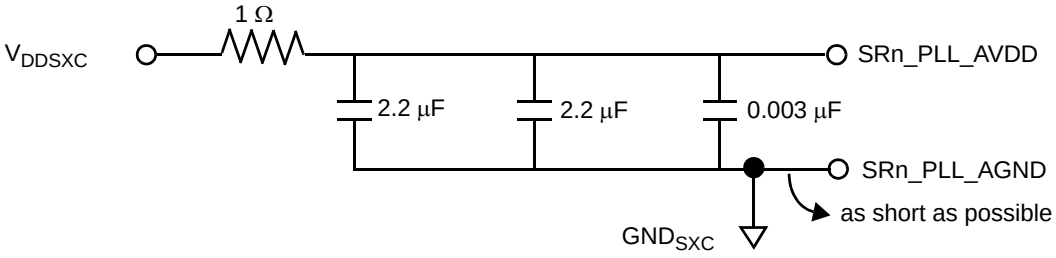


Figure 38. SerDes PLL Supplies

3.3 Clock and Timing Signal Board Layout Considerations

When laying out the system board, use the following guidelines:

- Keep clock and timing signal paths as short as possible and route with 50 Ω impedance.
- Use a serial termination resistor placed close to the clock buffer to minimize signal reflection. Use the following equation to compute the resistor value:

  Rterm = Rim – Rbuf

  where Rim = trace characteristic impedance

  Rbuf = clock buffer internal impedance.

3.4 SGMII AC-Coupled Serial Link Connection Example

Figure 39 shows an example of a 4-wire AC-coupled serial link connection. For additional layout suggestions, see *AN3556 MSC815x High Speed Serial Interface Hardware Design Considerations*, available on the Freescale website or from your local sales office or representative.

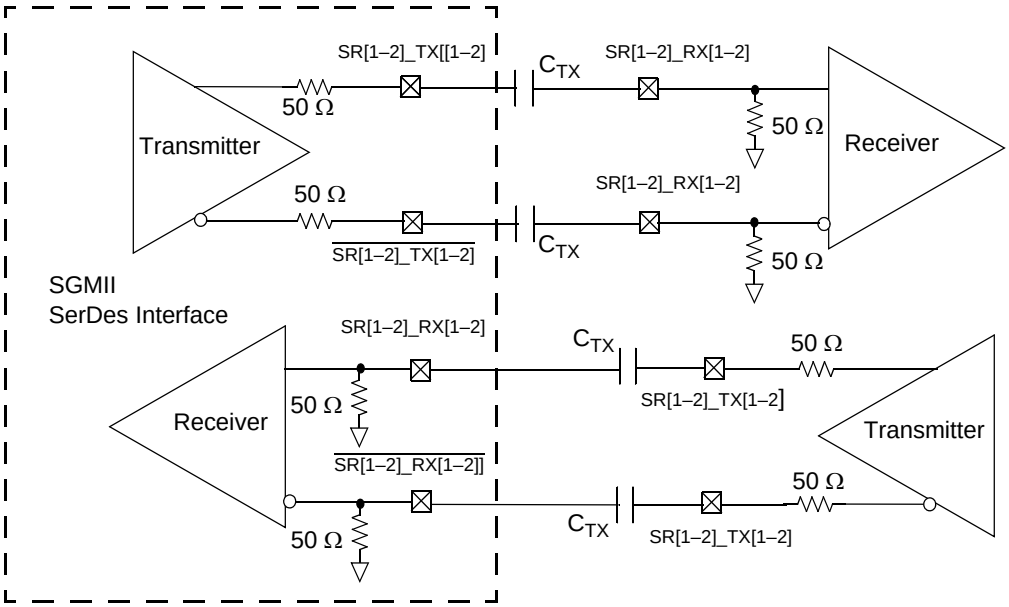


Figure 39. 4-Wire AC-Coupled SGMII Serial Link Connection Example

3.5.1 DDR Memory Related Pins

This section discusses the various scenarios that can be used with either of the MSC8151 DDR ports.

Note: The signal names in Table 40, Table 41 and Table 42 are generic names for a DDR SDRAM interface. For actual pin names refer to Table 1.

3.5.1.1 DDR Interface Is Not Used

Table 40. Connectivity of DDR Related Pins When the DDR Interface Is Not Used

Signal Name	Pin Connection
MDQ[0–63]	NC
MDQS[7–0]	NC
$\overline{\text{MDQS[7–0]}}$	NC
MA[15–0]	NC
MCK[0–2]	NC
$\overline{\text{MCK[0–2]}}$	NC
$\overline{\text{MCS[1–0]}}$	NC
MDM[7–0]	NC
MBA[2–0]	NC
$\overline{\text{MCAS}}$	NC
MCKE[1–0]	NC
MODT[1–0]	NC
MMDIC[1–0]	NC
$\overline{\text{MRAS}}$	NC
$\overline{\text{MWE}}$	NC
MECC[7–0]	NC
MDM8	NC
MDQS8	NC
$\overline{\text{MDQS8}}$	NC
MAPAR_OUT	NC
$\overline{\text{MAPAR\_IN}}$	NC
MVREF[3]	NC
GVDD1/GVDD2[3]	NC

Notes:
1. For the signals listed in this table, the initial M stands for M1 or M2 depending on which DDR controller is not used.
2. If the DDR controller is not used, disable the internal DDR clock by setting the appropriate bit in the System Clock Control Register (SCCR) and put all DDR I/O in sleep mode by setting DRx_GCR[DDRx_DOZE] (for DDR controller x). See the *Clocks* and *General Configuration Registers* chapters in the ***MSC8151 Reference Manual*** for details.
3. For MSC8151 Revision 1 silicon, these pins were connected to GND. For newer revisions of the MSC8151, connecting these pins to GND increases device power consumption.

3.5.1.4 DDR2 Unused MAPAR Pin Connections

When the MAPAR signals are not used, refer to Table 43 to determine the correct pin connections.

Table 43. Connectivity of MAPAR Pins for DDR2

Signal Name	Pin connection
MAPAR_OUT	NC
$\overline{\text{MAPAR\_IN}}$	NC

Notes: 1. For the signals listed in this table, the initial M stands for M1 or M2 depending on which DDR controller is used for DDR2.
2. For MSC8151 Revision 1 silicon, these pins were connected to GND. For newer revisions of the MSC8151, connecting these pins to GND increases device power consumption.

3.5.2 HSSI-Related Pins

3.5.2.1 HSSI Port Is Not Used

The signal names in Table 44 and Table 45 are generic names for a RapidIO interface. For actual pin names refer to Table 1.

Table 44. Connectivity of Serial RapidIO Interface Related Pins When the RapidIO Interface Is Not Used

Signal Name	Pin Connection
SR_IMP_CAL_RX	NC
SR_IMP_CAL_TX	NC
$\overline{\text{SR[1–2]\_REF\_CLK}}$	SXCVSS
SR[1–2]_REF_CLK	SXCVSS
SR[1–2]_RXD[3–0]	SXCVSS
$\overline{\text{SR[1–2]\_RXD[3–0]}}$	SXCVSS
$\overline{\text{SR[1–2]\_TXD[3–0]}}$	NC
SR[1–2]_TXD[3–0]	NC
SR[1–2]_PLL_AVDD	In use
SR[1–2]_PLL_AGND	In use
SXPVSS	In use
SXCVSS	In use
SXPVDD	In use
SXCVDD	In use

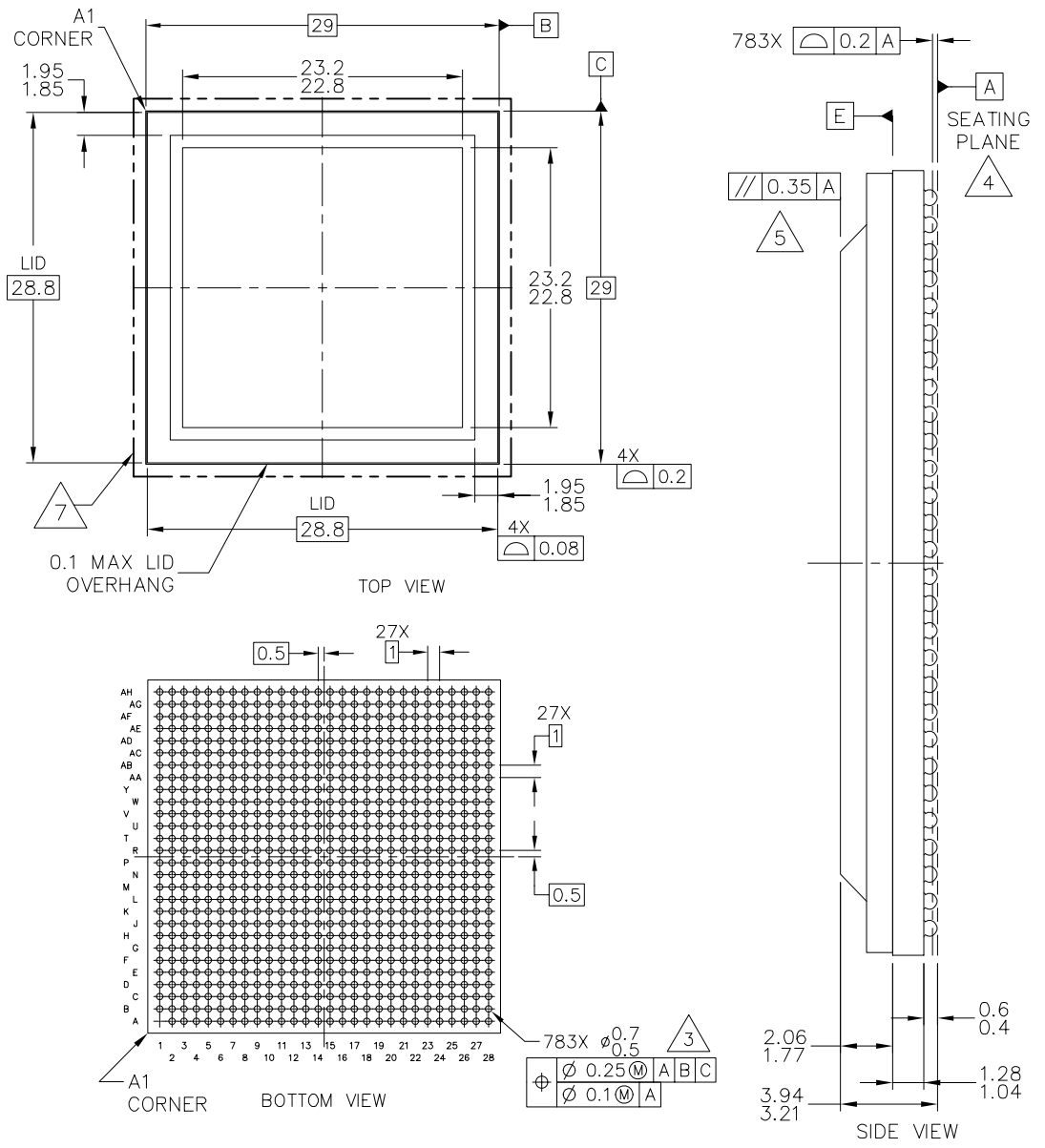
Note: All lanes in the HSSI SerDes should be powered down. Refer to the *MSC8151 Reference Manual* for details.

3.5.2.2 HSSI Specific Lane Is Not Used

Table 45. Connectivity of HSSI Related Pins When Specific Lane Is Not Used

Signal Name	Pin Connection
SR_IMP_CAL_RX	In use
SR_IMP_CAL_TX	In use
$\overline{\text{SR[1–2]\_REF\_CLK}}$	In use
SR[1–2]_REF_CLK	In use

5 Package Information



NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. MAXIMUM SOLDER BALL DIAMETER MEASURE PARALLEL TO DATUM A.
4. DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
5. PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.
6. ALL DIMENSIONS ARE SYMMETRIC ACROSS THE PACKAGE CENTER LINES, UNLESS DIMENSIONED OTHERWISE.
7. 29.2MM MAXIMUM PACKAGE ASSEMBLY (LID + LAMINATE) X AND Y.

Figure 40. MSC8151 Mechanical Information, 783-ball FC-PBGA Package